

Supplementary Figure 1. (a)-(d) HAADF images of pristine $Pt_3Co NPs$ show excellent size homogeneity and monodispersivity on supporting carbon.



Supplementary Figure 2. Atomic-resolution bright-field (BF) STEM images of the single Pt₃Co NP that were acquired simultaneously with the HAADF-STEM images in Fig. 2.



Supplementary Figure 3. Energy-dispersive X-ray spectra of the NP in Fig. 2 pre- and post-annealing. Both spectra were acquired at RT; the post-annealing spectrum was acquired after the particle was quenched from 800°C to RT. Both the spectra (a) and the corresponding elemental quantification (b) show no detectable chemical loss on the NP.



Supplementary Figure 4. Additional representative Pt_3Co NPs showed the same segregation behavior at different annealing temperatures as exhibited by the particle in Figs. 2 and 3. The enhanced contrast at the surface region was observed on the 350°C annealed particles, as marked by arrows on the profiles.



Supplementary Figure 5. Fast Fourier transforms computed from selected high-resolution images in Fig. 2. The representative ordering periodicities $\frac{1}{2}\{001\}$ and $\frac{1}{2}\{011\}$ are indicated by arrows.



Supplementary Figure 6. calculated structural models of Pt₃Co NPs for multi-slice STEM image simulations: randomly alloyed NP in a cubo-octahedron shape (a); after structural relaxation (b); and with Pt segregation (c).



$$z = \frac{c}{(1+\sqrt{2})}$$
(6)

Supplementary Figure 7. Schematic of facets and calculation equations that are used for estimating enclosing facet area of the NP. The 3D schematic model of truncated cubooctahedron (a) and its 2-D projection at [110] direction (b); the lengths of a_i, b_i, and c_i (i=1,2,3...) are measured from STEM images for facet evaluations. A truncated cubo-octahedron contains 8X{111}, 6X{100} and 12X{110} facets (c). x, y, and z are the side lengths of the (100) facets, and a, b, and c are the averages from the measured a_i , b_i , and c_i values respectively. The area of surface facets are calculated using equation (1)-(3), and the mathematic relationship between x, y, z and a, b, c are shown in equation (4)-(6).

Supplementary Table 1. Microscopy parameters for image simulation

| Voltage | Conver | C1 | A1 | A2 | B2 | С3 | A3 | A4 |
|---------|---------|-----------|------|------|------|-------|-------|------|
| (kV) | gent | | | | | | | |
| | angle | | | | | | | |
| 200 | 30 mrad | 700 | 2.22 | 35.5 | 30.4 | 100.1 | 264.7 | 8.1 |
| | | | | 0010 | 0011 | | | 0.12 |
| | | pm | nm | nm | nm | nm | nm | um |